

Anomaly detection: detection of fruit defects

Grzegorz Cielniak & Adrian Salazar

G.Cielniak@lincoln.ac.uk & asalazargomez@lincoln.ac.uk



Department of Computer Sciences & L-CAS & LAR
University of Lincoln

" Anomaly detection is the process of identifying data instances that significantly deviate from the majority of data instances"

In agriculture we can use anomaly detection tools to detect pest and diseases....

*" In agriculture, anomaly detection is the process of identifying **crops** that significantly deviate from the **normal and healthy crops**"*

- ▶ **Important for phenotyping breed disease resistant crops**
- ▶ **Anomalies mean significant losses to farmers**
 - Global yield losses projected to increase by 10 to 25% due to the increase pests in a warming climate[1]
 - Currently, pest and diseases reduce 10% to 30% the yield of the most important crops [2]
- ▶ **Traditional methods to early detect anomalies**
 - Visual assessment of expert agronomists
 - Prone to human errors, unattainable in large plantations, expensive

Anomaly data is:

- **Poorly sampled** → Hard to obtain in comparison with normal data



Most of the samples are normal

- **Hard to define** → Unlimited number of anomaly manifestations



Same anomaly? → Yes

- **Requires experts to label the data** → Not always available

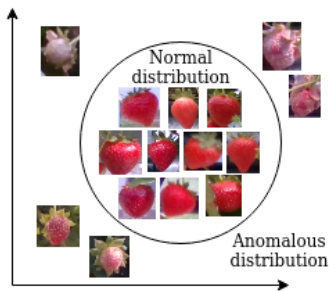


Is it an anomaly? → Yes, What kind of anomaly? → ???

- ▶ **Supervised methods** do not work well to identify anomalies
 - Supervised models require a substantial number of training samples
 - Supervised require accurate labels
 - Supervised method are sensitive to unbalanced dataset
- ▶ **Pure unsupervised methods** do not work well to identify anomalies
 - Challenging to learn commonalities within data in a complex and high dimensional space
 - Unsupervised techniques techniques are very sensitive to noise
 - Often requires hyper-parameter tuning for optimal results

Solution → One class classification

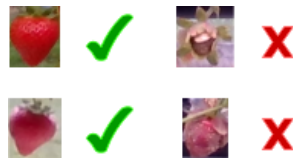
- ▶ Recognise instances of a concept (normality) by only using examples of the same concept



(a) One class classifier for anomaly detection

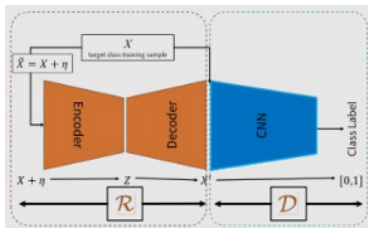


(b) Training data



(c) Test data

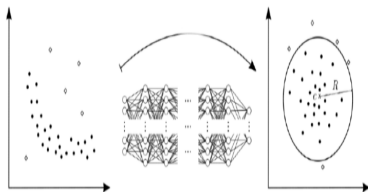
Two main frameworks to perform One-class classification:



(a) Generic OC methods:
Learn normality from an objective function that is **not focused on** anomaly detection
e.g. Autoencoders & GANs

$$\Theta^*, \mathbf{W}^* = \arg \min_{\Theta, \mathbf{W}} \sum_{x \in \mathcal{X}} \ell(\psi(\phi(x; \Theta); \mathbf{W})),$$

$$s_x = f(x, \phi_{\Theta^*}, \psi_{\mathbf{W}^*})$$



(b) Anomaly based OC methods:
Learn normality from an objective function **focused on** anomaly detection
e.g. Deep SVDD & DOC

$$\Theta^*, \mathbf{W}^* = \arg \min_{\Theta, \mathbf{W}} \sum_{x \in \mathcal{X}} \ell(f(\phi(x; \Theta); \mathbf{W})),$$

$$s_x = f(\phi(x; \Theta); \mathbf{W})$$

Where s_x is the anomaly score for image x , $f(\cdot)$ is a function that maps a feature space into s_x , $\phi(\cdot, \Theta)$ in an encoding function, $\psi(\cdot, \mathbf{W})$ is a surrogate function that operates in the encoded feature space, and $\ell(\cdot)$ is the objective function

- ▶ Data from Riseholme poly tunnels (2018)
- ▶ **3 Training (Normality) sets:**
 - **normal: ripe:** 462 ripe strawberries
 - **normal: ripe + ripe occluded:** 462 ripe strawberries + 462 ripe occluded strawberries
 - **normal: ripe + unripe:** 462 ripe strawberries + 462 unripe strawberries
- ▶ **Test set** 110 anomalous strawberries + 110 instances from training set



Dataset Riseholme 2018

Used models:

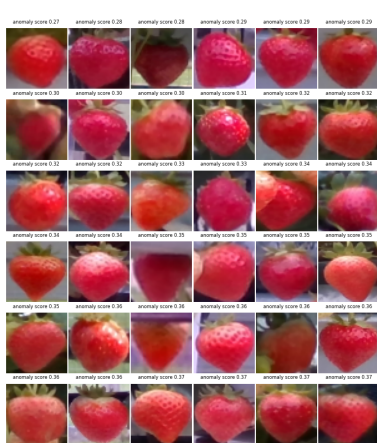
- ▶ Autoencoder for AD [3]
- ▶ Deep One-class transfer learning (DOC) [4]
- ▶ Deep Support Vector Data Description (Deep SVDD) [5]

	Autoencoder	Deep SVDD	DOC
AUC (normal: ripe)	0.67	0.95	0.79
AUC (normal: ripe + ripe occluded)	0.59	0.80	0.63
AUC (normal: ripe + unripe)	0.58	0.75	0.52

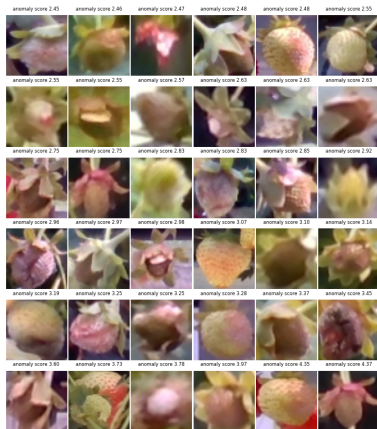
Table 1: Results implemented methods

- ▶ Performance drops as normal data (training) is less concise e.g. ripe + unripe

Training set: Ripe \rightarrow 0.95 AUC



(a) Deep SVDD, Most normal instances using ripe strawberries for training



(b) Deep SVDD, Most anomalous instances using ripe strawberries for training

Training set: Ripe + Ripe Occluded \rightarrow 0.75 AUC

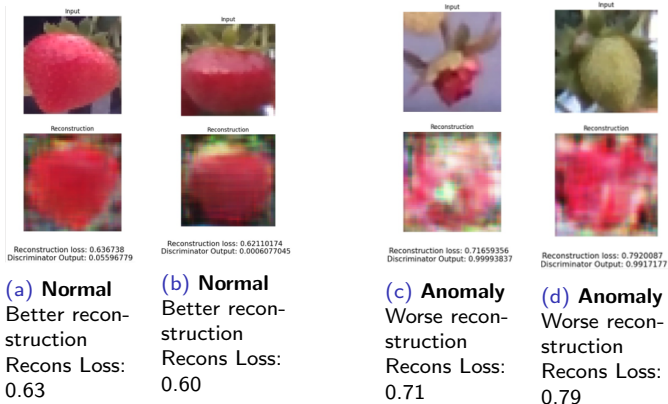


(a) Deep SVDD, Most normal instances using ripe and unripe strawberries for training



(b) Deep SVDD, Most anomalous instances using ripe and unripe strawberries for training

- ▶ **Model:** Autoencoder for AD [3]
- ▶ **Performance:** 0.67 AUC (Sensitive to parameters)



► Improve current methods:

- Make One-class anomaly detectors robust to poorly defined normally class (multi-modal one-class?, ensembles?)
- Try different approaches/structures
- Purify training sets & better datasets

► Increase anomaly types: e.g. insects and leaves



(a) Insect,
(Riseholme 2020)



(b) Pest,
(Riseholme 2020)



(c) Pest,
(Riseholme 2020)



(d) Pest,
(Riseholme 2020)

- ▶ **Implement** alongside the object detectors created at L-CAS e.g.



Future plans: Object detector + Anomaly detector

- ▶ **Explore Agri-robot-human interaction** Use it to raise flags . If anomaly score is high call agronomist (RHI, Active learning)
- ▶ **New and detailed anomaly dataset in process**

THANK YOU

- [1] C. A. Deutsch, J. J. Tewksbury, M. Tigchelaar, D. S. Battisti, S. C. Merrill, R. B. Huey, and R. L. Naylor, “Increase in crop losses to insect pests in a warming climate,” *Science*, vol. 361, no. 6405, pp. 916–919, 2018.
- [2] S. Savary, L. Willocquet, S. J. Pethybridge, P. Esker, N. McRoberts, and A. Nelson, “The global burden of pathogens and pests on major food crops,” *Nature ecology & evolution*, vol. 3, no. 3, pp. 430–439, 2019.
- [3] A. Makhzani and B. J. Frey, “Winner-take-all autoencoders,” in *Advances in neural information processing systems*, 2015, pp. 2791–2799.
- [4] P. Perera and V. M. Patel, “Learning deep features for one-class classification,” *IEEE Transactions on Image Processing*, vol. 28, no. 11, pp. 5450–5463, 2019.
- [5] L. Ruff, R. Vandermeulen, N. Goernitz, L. Deecke, S. A. Siddiqui, A. Binder, E. Müller, and M. Kloft, “Deep one-class classification,” in *International conference on machine learning*, 2018, pp. 4393–4402.